

Search Notes

Application/Control No.

10/733,416

Examiner

Yonel Beaulieu

Applicant(s)/Patent under
Reexamination

SAKURAI ET AL.

Art Unit

3661

SEARCHED

Class	Subclass	Date	Examiner
701	22	11/1/2006	YB
	36		
307	9.1		
	10.1		
	10.6		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST	11/1/2006	YB